Magnetic field induced reconstruction of electronic structure in Sr₃Ru₂O₇ nanosheets

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The origin of the large magnetoresistance (MR) peak induced by the metamagnetic transition (MMT) in $Sr_3Ru_2O_7$ has attracted extensive attention, but still remains puzzling. Here we performed systematic magnetotransport and torque magnetometry measurements of $Sr_3Ru_2O_7$ nanosheets, and found surprisingly that the MR peak, together with the MMT, shifts dramatically toward low magnetic field with the decrease of thickness. Meanwhile, the Hall coefficient shows clearly a sign change near the MR peak position, indicating a magnetic field induced change of band topology. Combined with the theoretical calculation, we argue that the nature of the MR peak in $Sr_3Ru_2O_7$ is associated with the so-called Lifshitz transition due to van Hove singularity, which is closer to the Fermi level in thinner nanosheets.

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 $Sr_3Ru_2O_7$ belongs to the perovskite ruthenates of the Ruddlesden-Popper series $Sr_{n+1}Ru_nO_{3n+1}$ ($n=1,2,\infty$) with n=2 [1]. Contrasted with the n=1 member Sr_2RuO_4 , which is an unconventional superconductor [2–4], $Sr_3Ru_2O_7$ is a paramagnetic metal in its ground state [5], and shows two unusual metamagnetic transitions (MMTs), manifested by a superlinear increase in magnetization at critical magnetic fields of \sim 8 T and 13.5 T for H|lc (or \sim 5.5 T and 5.8 T for H|lab plane) [6,7]. A very striking and puzzling phenomenon is that, accompanied by the first MMT, the magnetoresistance (MR) exhibits simultaneously a huge peak [6–8]. Although this phenomenon has been extensively studied for decades [6,8–11], its nature remains controversial.

One theoretical work based on the phenomenological Ginzburg-Landau theory suggests that the MR peak at the first MMT may be caused by the magnetic Condon domain wall scattering of electrons [12], but a subsequent experimental study suggests it may originate from the magnetic field induced electronic nematic order (ENO) [10,13–15], which is manifested by the formation of a spin density wave (SDW) [11]. Thus, the MR peak is reasonably attributed to the gapping out of Fermi surface or the SDW domain wall scattering

of electrons [11]. However, the entropy and specific heat experiments [16–18] show that there are still large number of carriers at the MR peak position, suggesting the former might be ruled out. Unfortunately, the domain scenario is also challenged by a recent domain tuning experiment [19], in which no hysteresis in the MR curves is observed by repeatedly driving the magnetic field passing over or across the critical field at the MR peak.

Previously, few were known when the thickness of Sr₃Ru₂O₇ is in the nanometer scale. A recent transport experiment on the 20 nm-thick Sr₃Ru₂O₇ thin film shows that the electron nematic phase can be promoted to much higher temperatures and over a larger magnetic field range than in bulk single crystals, which is attributed to the strain effect arising from the lattice mismatch between the film and substrate [20]. In this work, we focus on the MR behavior of single crystalline Sr₃Ru₂O₇ nanosheets, which are freestanding on the Si/SiO₂ substrate. We found the MR peak shifts considerably toward low magnetic fields with the decrease of nanosheet thickness. Hall effect and magnetic property measurements reveal that there is a magnetic field induced sign change of the Hall coefficient at the MR peak position, suggesting a possible Lifshitz transition. Theoretical calculation shows that the above results can be understood by the van Hove singularity, which is closer to the Fermi level in thinner nanosheets.

The preparation of nanosheets for experimental measurements is presented in the Supplemental Material [21]. Figure 1 shows the resistance (R) versus temperature (T) curve of a $Sr_3Ru_2O_7$ nanosheet with a thickness d of 30 nm, where the

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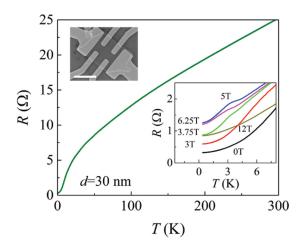


FIG. 1. Temperature (T) dependent resistance (R) of a 30 nm-thick $Sr_3Ru_2O_7$ nanosheet. Insets: (Top) A scanning electronic microscopy image of the nanosheet. Scale bar: 3 μ m. (Bottom) Magnetic field dependence of the R-T behavior of the 30 nm-thick nanosheet.

top inset shows a scanning electronic microscopy image of the nanosheet. It is found that the R decreases monotonically with decreasing T, with a residual resistance ratio (RRR) of about 80, which is in line with those reported in bulk Sr₃Ru₂O₇ single crystals [5,9]. The enlargement of the R-T curves at different magnetic fields is shown in the bottom inset, a kink at \sim 4.0 K emerges clearly when the magnetic field H is near 5.0 T. A similar H-dependent R-T property showing kinks at \sim 4.0 K is also observed in 200 nm-thick nanosheet [21]. It has been reported that a H-dependent kink in the R-T curve can be observed only below ~1.0 K in ultrapure single crystalline Sr₃Ru₂O₇ bulk [22] due to the formation of magnetic field induced ENO or SDW [10,11,13]. Our results indicate that the characteristic temperature showing the unusual kinks in nanosheets is much higher than ~ 1.0 K due to the thickness confinement effect. All nanosheets used in this work exhibit very similar R-T dependence, indicating our samples do not involve intergrowth with either Sr₄Ru₃O₁₀ or SrRuO₃ [23].

Figure 2 shows R-H curves of nanosheets with various thickness measured at 0.5 K with $H \parallel c$. No hysteresis is observed in the MR when sweeping the magnetic field back and forth, which is consistent with previous reports of bulk samples [6,8]. A significant feature is that the peak position (H_p) of the MR shifts dramatically toward the low field with decreasing the thickness. The detailed definition of H_p is presented in Fig. S3 [21]. For comparison, the R-H curve of a $Sr_3Ru_2O_7$ bulk single crystal measured with $H \parallel c$ is plotted in the inset of Fig. 2(a), where the H_p is \sim 7.9 T.

It is well known that the MR peak for a bulk sample takes place at the MMT, with a critical field identical to H_p . However, for a nanosheet, it is unclear whether its MMT also follows the similar thickness dependence of the MR. In general, it is very challenging to obtain the magnetization data on a nanosheet due to its extreme small magnetic moments. Here, we performed torque magnetometry measurements on $Sr_3Ru_2O_7$ nanosheets using an ultrasensitive cantilever with low spring constant (~ 10 mN/m) [24,25]. With this technique, a single piece of the $Sr_3Ru_2O_7$ nanosheet was attached

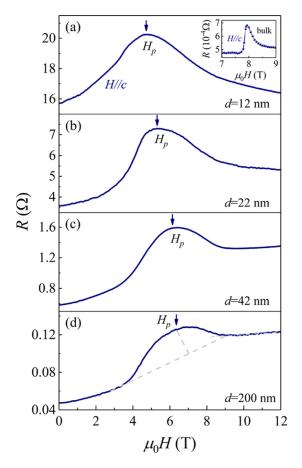


FIG. 2. Magnetic field dependent resistance for different-thickness $Sr_3Ru_2O_7$ nanosheets measured at 0.5 K with $H\|c$. (a) d=12 nm (b) d=22 nm; (c) d=42 nm; (d) d=200 nm. Inset in (a): R-H curve of a $Sr_3Ru_2O_7$ bulk single crystal with $H\|c$ at 0.5 K.

to the free end of the Si cantilever, as shown in Fig. 3(a). When a magnetic field is applied, the magnetic torque $\tau = M \times H$ (M: magnetization) would induce a displacement Δx of the cantilever, which is in proportion to τ .

Figures 3(b) and 3(c) show, respectively, the H-dependent τ of 800 nm- and 200 nm-thick nanosheets measured at 2.2 K and 1.6 K, where θ is the angle between the H and the ab plane of the nanosheet, as schematically shown in the inset of Fig. 3(b). Two successive transitions at critical fields of H_{c1} and H_{c2} , which must correspond to the first and second MMTs, can be identified from the $d\tau/dH$ -H plot, as representatively shown in the inset of Fig. 3(c) [7]. The angle θ -dependent H_{c1} and H_{c2} of the two samples are summarized in Figs. 3(d) and 3(e), respectively. It is found that both H_{c1} and H_{c2} decrease with decreasing θ , which is consistent with previous magnetic torque measurements of a bulk sample [7]. The facts that both H_{c1} and H_{c2} are reduced significantly with decreasing thickness for $H \parallel c$ compared with the bulk $(H_{c1} \sim 8 \text{ T}, H_{c2} \sim 13.5 \text{ T} \text{ [7]})$, and the magnitude of H_{c1} is almost identical to H_p in the 200 nm-thick nanosheet, suggest the MMTs and the MR peak indeed share a same thicknessdependent behavior as expected.

To understand the origin of the MR peak at the MMT, we performed systematic Hall resistivity measurements at

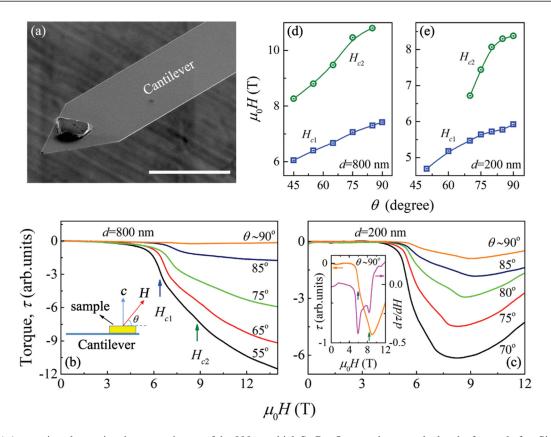


FIG. 3. (a) A scanning electronic microscopy image of the 800 nm-thick $Sr_3Ru_2O_7$ nanosheet attached at the free end of an Si cantilever for the torque magnetometry measurement. Scale bar: $100 \ \mu m$. (b) and (c) are, respectively, the magnetic field dependent torque as a function of the angle θ defined in the inset of (b) of the 800 nm-thick nanosheet measured at T=2.2 K and the 200 nm-thick nanosheet measured at T=1.6 K. Inset of (c) is an enlarged view of the magnetic field dependent torque (left axis) and its corresponding derivative (right axis) measured near $\theta \sim 90^{\circ}$ of the 200 nm-thick nanosheet, where the first and second magnetic transition critical fields H_{c1} and H_{c2} are, respectively, defined at the minimum of the $d\tau/dM-H$ curve. (d) and (e) are, respectively, the angle-dependent critical fields of the 800 nm and 200 nm-thick nanosheets.

0.5 K on several nanosheets as shown in Fig. 4(a), where $\rho_{xy} = [\rho_{xy}(H) - \rho_{xy}(-H)]/2$ is obtained by symmetrizing the data with positive and negative field cycles. One can find that ρ_{xy} increases linearly with increasing H up to a magnetic field of H_1 , then changes its slope from positive to negative with three distinguishable kinks at H_1 , H_2 , and H_3 , respectively, as labeled by the arrows. Note that the kinks above H_1 are not distinguishable in the Sr₃Ru₂O₇ bulk reported in Ref. [26]. The critical fields at the kinks are summarized in Fig. 4(b) as a function of nanosheet thickness, d. It is clearly seen that H_3 is almost thickness independent for d < 200 nm, and remains at ~ 10 T. However, H_1 and H_2 decrease with decreasing thickness, which almost follow the same thickness-dependent behavior of the MR peak and the MMT [see Fig. 4(b) and Fig. S4 [21], H_1 : " \triangle ", H_p : " \updownarrow ", H_{c1} : " \square ", H_2 : " \bigcirc ", H_{c2} : " \diamondsuit "]. These results indicate that the kinks at H_1 and H_2 in ρ_{xy} must correspond to H_{c1} (or H_p of the MR) and H_{c2} of the MMT. H_3 can thus reasonably be considered as a characteristic field of the magnetic field induced high moment phase [11].

As a metamagnetic metal of $Sr_3Ru_2O_7$, its total Hall resistivity, ρ_{xy} , should involve both ordinary Hall effect (OHE) and anomalous Hall effect (AHE) with $\rho_{xy} = R_H^{OHE}H + R_H^{AHE}M$ [27], where M is the magnetization along the c axis, R_H^{OHE} and R_H^{AHE} are, respectively, the ordinary and anomalous Hall coefficients. However, combined with the

magnetic measurements, we conclude that the AHE has less contribution to ρ_{xy} . This is based on the observation that in the MMT range of $H_1 < H < H_3$, as shown in Fig. S1 [21] and Ref. [6,11], the change of magnetization is $\sim 0.1 \mu_B/Ru$ per Tesla, which is about five times larger than that outside of this region, but the variation of ρ_{xy} at $H_1 < H < H_3$ is not so significant compared with that at $H < H_1$ and $H > H_3$, which is completely contrary to the AHE theory [27]. Since the traces of the ρ_{xy} -H curves for nanosheets of different thicknesses, as shown in Fig. 4(a), are almost parallel to each other at low fields ($< H_1$), suggesting the transport property of the nanosheet is less dependent on the thickness below H_1 . The low field (<*H*₁) Hall coefficient R_H , extracted from the slope of the ρ_{xy} -H curves, is about 2×10^{-10} m³/C [Fig. 4(c)], which is consistent with that determined from bulk samples [28,29]. Strikingly, a clear sign change of R_H from positive at $H < H_1$ to negative at $H > H_3$ in each $Sr_3Ru_2O_7$ nanosheet is observed [Fig. 4(c)], indicating there possibly exists a magnetic field induced band structure reconstruction [21]. One possibility is the so-called Lifshitz (LF) transition where the Fermi surface topology changes due to the variations of the Fermi energy and/or the band structure [30]. Such a LF transition effectively modifies the transport properties, hence the MR peaks at the transition field. The fact that above H_3 , R_H decreases with decreasing thickness [Fig. 4(c)], indicates that

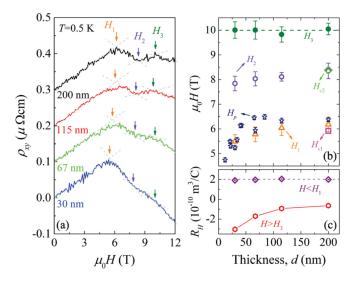


FIG. 4. (a) Magnetic field dependent Hall resistivity ρ_{xy} of $\operatorname{Sr}_3\operatorname{Ru}_2\operatorname{O}_7$ nanosheets with different thicknesses d measured at 0.5 K. The kinks of the ρ_{xy} -H slope changes are labeled as H_1 , H_2 , H_3 , respectively. Curves are shifted vertically by 0.1 $\mu\Omega$ cm for clarity. (b) Magnetic field H versus nanosheet thickness d. The characteristic fields, H_p , H_1 , H_2 , H_3 , and the critical fields of H_{c1} and H_{c2} , are labeled by symbols " $\dot{\sim}$ ", " $\dot{\sim}$ ", $\dot{\odot}$, \bullet , " \Box ", " $\dot{\circ}$ " respectively. (c) Thickness dependence of the Hall coefficient R_H at $H < H_1$ and $H > H_3$.

the MMT and the accompanied MR peak are indeed sensitive to the band structure or the position of the Fermi level (E_F) .

LF transition can be induced by chemical doping or pressure through continuously tuning the filling of a band or the shape of a Fermi surface, as already argued in cuprates [31], iron pnictides [32], and topological materials [33], etc. LF transition can also be driven by a magnetic field through coupling with the Zeeman term, but it is usually achieved in heavy fermion system when the Fermi energy is significantly reduced due to the hybridization of the conduction and the localized f electrons [34,35]. The observation of magnetic field induced LF transition under low magnetic fields ($H_1 \sim 6 \text{ T}$) in Sr₃Ru₂O₇ is extremely striking, since its Zeeman energy is small [36]. However, our observation seems to be a reminiscent of recent theoretical studies [37–41], showing the MMT in Sr₃Ru₂O₇ is related to a van Hove singularity in the density of state (DOS). In this scenario, the band feature is considered to be very sensitive to small energy scales and the Zeeman energy tends to reconstruct the Fermi surface via strong spin orbital coupling and/or quenching of orbital moments rather than just causing a relative chemical potential shift

To get an insight into the thickness-dependent H_p (or H_1), density functional theory (DFT) calculations are performed [21]. It was known that the structure relaxation for a $Sr_3Ru_2O_7$ sheet including only two $Sr_3Ru_2O_7$ units along the c direction causes a slight expansion of the lattice constant c to be 2.085 nm through a total energy minimization, compared to 2.059 nm for a bulk structure, indicating the c more likely increases with the decrease of nanosheet thickness (this is qualitatively consistent with our experimental observation [21]). Similar lattice change is reported in thin

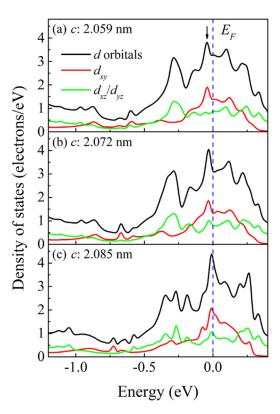


FIG. 5. Partial density of states for the Ru d orbitals with (a) c = 2.059 nm, (b) c = 2.072 nm, and (c) c = 2.085 nm. The arrow in (a) denotes a van Hove singularity.

transition-metal dichalcogenides [42]. Figure 5 presents the partial density of state (PDOS) of Ru with different lattice constant c; the total DOS is shown in the Supplemental Material [21]. A sharp peak near the E_F of the PDOS referred to a van Hove singularity, which is marked by the arrow in Fig. 5(a) can be found, consistent with previous theoretical calculation [38]. Interestingly, we found the van Hove singularity shifts toward the E_F as c increases. Since the position of the van Hove singularity is mainly determined by the d_{xy} orbital of Ru (Fig. 5), such a shift can thus be attributed to the change of crystal field. When c increases, the elongated RuO_6 octahedra causes the d_{xy} orbital to be upward shifted relative to the d_{xz}/d_{yz} orbitals. In Ca₂RuO₄ and Ca₃Ru₂O₇, it has been reported that the flattening of RuO₆ octahedra causes the downward shift of the d_{xy} orbital, leading to an orbital polarization [43,44]. Considering the van Hove singularity is responsible for the MMT (e.g., Ref. [41]) and the sign change of R_H shown in Fig. 4(c), the thickness-tuned shift of the van Hove singularity towards the E_F might be the origin of the thickness-dependent MR peak or the MMT as well as the magnetic field induced LF transition.

In summary, we have systematically studied the thickness dependence of magnetotransport and magnetic properties of Sr₃Ru₂O₇ single crystalline nanosheets. We found that the first MMT as well as its resulting MR peak shift to low magnetic field with decreasing thickness. Combined with the Hall resistivity and torque magnetometry measurements, and the DFT calculation, we argue that the anomalous MR peak at the MMT might originate from a magnetic field induced LF transition due to van Hove singularity.

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- H. Shaked, J. D. Jorgensen, O. Chmaissem, S. Ikeda, and Y. Maeno, J. Solid State Chem. 154, 361 (2000).
- [2] K. Ishida, H. Mukuda, Y. Kitaoka, K. Asayama, Z. Q. Mao, Y. Mori, and Y. Maeno, Nature (London) 396, 658 (1998).
- [3] C. W. Hicks, D. O. Brodsky, E. A. Yelland, A. S. Gibbs, J. A. N. Bruin, M. E. Barber, S. D. Edkins, K. Nishimura, S. Yonezawa, Y. Maeno, and A. P. Mackenzie, Science 344, 283 (2014).
- [4] A. Steppke, L. Zhao, M. E. Barber, T. Scaffidi, F. Jerzembeck, H. Rosner, A. S. Gibbs, Y. Maeno, S. H. Simon, A. P. Mackenzie, and C. W. Hicks, Science 355, eaaf9398 (2017).
- [5] S.-I. Ikeda, Y. Maeno, S. Nakatsuji, M. Kosaka, and Y. Uwatoko, Phys. Rev. B 62, R6089 (2000).
- [6] R. S. Perry, L. M. Galvin, S. A. Grigera, L. Capogna, A. J. Schofield, A. P. Mackenzie, M. Chiao, S. R. Julian, S. I. Ikeda, S. Nakatsuji, Y. Maeno, and C. Pfleiderer, Phys. Rev. Lett. 86, 2661 (2001).
- [7] E. Ohmichi, Y. Yoshida, S. I. Ikeda, N. V. Mushunikov, T. Goto, and T. Osada, Phys. Rev. B 67, 024432 (2003).
- [8] S. A. Grigera, P. Gegenwart, R. A. Borzi, F. Weickert, A. J. Schofield, R. S. Perry, T. Tayama, T. Sakakibara, Y. Maeno, A. G. Green, and A. P. Mackenzie, Science 306, 1154 (2004).
- [9] S. A. Grigera, R. S. Perry, A. J. Schofield, M. Chiao, S. R. Julian, G. G. Lonzarich, S. I. Ikeda, Y. Maeno, A. J. Millis, and A. P. Mackenzie, Science 294, 329 (2001).
- [10] R. A. Borzi, S. A. Grigera, J. Farrell, R. S. Perry, S. J. S. Lister, S. L. Lee, D. A. Tennant, Y. Maeno, and A. P. Mackenzie, Science 315, 214 (2007).
- [11] C. Lester, S. Ramos, R. S. Perry, T. P. Croft, R. I. Bewley, T. Guidi, P. Manuel, D. D. Khalyavin, E. M. Forgan, and S. M. Hayden, Nature Mater. 14, 373 (2015).
- [12] B. Binz, H. B. Braun, T. M. Rice, and M. Sigrist, Phys. Rev. Lett. 96, 196406 (2006).
- [13] S. Raghu, A. Paramekanti, E. A. Kim, R. A. Borzi, S. A. Grigera, A. P. Mackenzie, and S. A. Kivelson, Phys. Rev. B 79, 214402 (2009).
- [14] H. Doh, Y. B. Kim, and K. H. Ahn, Phys. Rev. Lett. 98, 126407 (2007).
- [15] C. Stingl, R. S. Perry, Y. Maeno, and P. Gegenwart, Phys. Rev. Lett. 107, 026404 (2011).
- [16] A. W. Rost, R. S. Perry, J.-F. Mercure, A. P. Mackenzie, and S. A. Grigera, Science 325, 1360 (2009).
- [17] A. W. Rost, S. A. Grigera, J. A. N. Bruin, R. S. Perry, D. Tian, S. Raghu, S. A. Kivelson, and A. P. Mackenzie, Proc. Natl. Acad. Sci. 108, 16549 (2011).
- [18] Y. Tokiwa, M. Mchalwat, R. S. Perry, and P. Gegenwart, Phys. Rev. Lett. 116, 226402 (2016).
- [19] D. O. Brodsky, M. E. Barber, J. A. N. Bruin, R. A. Borzi, S. A. Grigera, R. S. Perry, A. P. Mackenzie, and C. W. Hicks, Sci. Adv. 3, e1501804 (2017).
- [20] P. B. Marshall, K. Ahadi, H. Kim, and S. Stemmer, Phys. Rev. B 97, 155160 (2018).

- [21] See Supplemental Material at http://link.aps.org/supplemental/ 10.1103/PhysRevB.102.195119 for details of (i) preparation of Sr₃Ru₂O₇ nanosheets, (ii) magnetic field dependent *R-T* data of the 200 nm-thick nanosheet, (iii) the extraction of *H_p*, (iv) thickness-dependent *H_p* of the MR, *H_{c1}* and *H_{c2}* of the MMT, *H*₁, *H*₂, and *H*₃ of the Hall resistivity in the thickness range of 0–800 nm, (v) analysis of the possible Lifshitz transition, (vi) calculation methods, (vii) total density of states of Sr₃Ru₂O₇ with different lattice constant *c*, (viii) the lattice parameter *c* of a 30 nm-thick Sr₃Ru₂O₇ nanosheet and the bulk single crystal. Includes additional references [1,6,7,28,45–50].
- [22] R. S. Perry, K. Kitagawa, S. A. Grigera, R. A. Borzi, A. P. Mackenzie, K. Ishida, and Y. Maeno, Phys. Rev. Lett. 92, 166602 (2004).
- [23] Y. Liu, W. Chu, J. Yang, G. Liu, H. Du, W. Ning, L. Ling, W. Tong, Z. Qu, G. Cao, Z. Xu, and M. Tian, Phys. Rev. B 98, 024425 (2018).
- [24] F. Xu, S. Guo, Y. Yu, N. Wang, L. Zou, B. Wang, R.-W. Li, and F. Xue, Phys. Rev. Appl. 11, 054007 (2019).
- [25] A. Mehlin, F. Xue, D. Liang, H. F. Du, M. J. Stolt, S. Jin, M. L. Tian, and M. Poggio, Nano Lett. 15, 4839 (2015).
- [26] R. A. Borzi, A. McCollam, J. A. N. Bruin, R. S. Perry, A. P. Mackenzie, and S. A. Grigera, Phys. Rev. B 84, 205112 (2011).
- [27] N. Nagaosa, J. Sinova, S. Onoda, A. H. MacDonald, and N. P. Ong, Rev. Mod. Phys. 82, 1539 (2010).
- [28] Y. Liu, R. Jin, Z. Q. Mao, K. D. Nelson, M. K. Haas, and R. J. Cava, Phys. Rev. B 63, 174435 (2001).
- [29] R. S. Perry, L. M. Galvin, A. P. Mackenzie, D. M. Forsythe, S. R. Julian, S. I. Ikeda, and Y. Maeno, Physica B 284, 1469 (2000).
- [30] I. M. Lifshitz, Soviet Physics-JETP 11, 1130 (1960).
- [31] D. LeBoeuf, N. Doiron-Leyraud, B. Vignolle, M. Sutherland, B. J. Ramshaw, J. Levallois, R. Daou, F. Laliberté, O. Cyr-Choinière, J. Chang, Y. J. Jo, L. Balicas, R. Liang, D. A. Bonn, W. N. Hardy, C. Proust, and L. Taillefer, Phys. Rev. B 83, 054506 (2011).
- [32] B. Lei, J. H. Cui, Z. J. Xiang, C. Shang, N. Z. Wang, G. J. Ye, X. G. Luo, T. Wu, Z. Sun, and X. H. Chen, Phys. Rev. Lett. 116, 077002 (2016).
- [33] G. E. Volovik, Low Temp. Phys. **43**, 47 (2017).
- [34] G. Bastien, A. Gourgout, D. Aoki, A. Pourret, I. Sheikin, G. Seyfarth, J. Flouquet, and G. Knebel, Phys. Rev. Lett. 117, 206401 (2016).
- [35] H. Pfau, R. Daou, S. Friedemann, S. Karbassi, S. Ghannadzadeh, R. Küchler, S. Hamann, A. Steppke, D. Sun, M. König, A. P. Mackenzie, K. Kliemt, C. Krellner, and M. Brando, Phys. Rev. Lett. 119, 126402 (2017).
- [36] K. Iwaya, S. Satow, T. Hanaguri, N. Shannon, Y. Yoshida, S. I. Ikeda, J. P. He, Y. Kaneko, Y. Tokura, T. Yamada, and H. Takagi, Phys. Rev. Lett. 99, 057208 (2007).
- [37] M. H. Fischer and M. Sigrist, Phys. Rev. B 81, 064435 (2010).

- [38] C. M. Puetter, J. G. Rau, and H.-Y. Kee, Phys. Rev. B **81**, 081105(R) (2010).
- [39] A. M. Berridge, Phys. Rev. B 83, 235127 (2011).
- [40] W.-C. Lee and C. Wu, Chin. Phys. Lett. 33, 037201 (2016).
- [41] M. Behrmann, C. Piefke, and F. Lechermann, Phys. Rev. B 86, 045130 (2012).
- [42] W. S. Yun, S. W. Han, S. C. Hong, I. G. Kim, and J. D. Lee, Phys. Rev. B 85, 033305 (2012).
- [43] J. H. Jung, Z. Fang, J. P. He, Y. Kaneko, Y. Okimoto, and Y. Tokura, Phys. Rev. Lett. **91**, 056403 (2003).
- [44] J. Peng, M. Q. Gu, X. M. Gu, G. T. Zhou, X. Y. Gao, J. Y. Liu, W. F. Xu, G. Q. Liu, X. Ke, L. Zhang, H. Han, Z. Qu, D. W. Fu, H. L. Cai, F. M. Zhang, Z. Q. Mao, and X. S. Wu, Phys. Rev. B 96, 205105 (2017).

- [45] A. B. Pippard, *Magnetoresistance in Metal* (Cambridge University Press, Cambridge, 1989), p.253.
- [46] A. Tamai, M. P. Allan, J. F. Mercure, W. Meevasana, R. Dunkel, D. H. Lu, R. S. Perry, A. P. Mackenzie, D. J. Singh, Z.-X. Shen, and F. Baumberger, Phys. Rev. Lett. 101, 026407 (2008).
- [47] N. P. Ong, Phys. Rev. B 43, 193 (1991).
- [48] A. P. Mackenzie, N. E. Hussey, A. J. Diver, S. R. Julian, Y. Maeno, S. Nishizaki, and T. Fujita, Phys. Rev. B 54, 7425 (1996).
- [49] G. Kresse and J. Furthmüller, Phys. Rev. B 54, 11169 (1996).
- [50] P. Blaha *et al.*, computer code WIEN2K, (TU Wien, Vienna, 2001).